

-	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/634,881	WILLEY ET AL.	
	Examiner	Art Unit	
	LEE NGUYEN	2618	

SEARCHED					
Class	Subclass	Date	Examiner		
455	410 411	12/6/2007	LN		
	41.2				
	41.3				
380	247 270				
713	168-172				
update	search	11/7/2007	LN		
	all above		n		
			_		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
455	410-411	11/7/2007	LN		
	41.2				
380	247				
SEE SEARCH HISTORY		11/7/2007	LN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPG-PUB; USPAT; JPO; EPO; DERWENT; IEEE) SEE SEARCH HISTORY	12/6/2007	LN		
,				